

<b>Notice of References Cited</b>	Application/Control No. 10/046,759		Applicant(s)/Patent Under Reexamination WATANABE ET AL.	
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#### U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-6,567,915	05-2003	Guthery, Scott B.	713/168
*	B	US-6,772,133	08-2004	Kambayashi et al.	705/57
*	C	US-5,123,045	06-1992	Ostrovsky et al.	713/190
*	D	US-6,535,016	03-2003	Choukalos et al.	326/8
*	E	US-6,510,502	01-2003	Shimizu, Yusuke	711/164
*	F	US-4,766,516	08-1988	Ozdemir et al.	361/820
*	G	US-5,903,650	05-1999	Ross et al.	705/59
*	H	US-4,924,378	05-1990	Hershey et al.	726/29
*	I	US-5,761,309	06-1998	Ohashi et al.	713/156
*	J	US-6,763,463	07-2004	Guthery, Scott B.	713/193
*	K	US-5,034,980	07-1991	Kubota, Satoshi	713/189
*	L	US-6,779,113	08-2004	Guthery, Scott B.	713/172
*	M	US-5,027,398	06-1991	Miyoshi, Akio	714/54

#### FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	O					
	P					
	Q					
	R					
	S					
	T					

#### NON-PATENT DOCUMENTS

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**U.S. PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-6,032,257	02-2000	Olarig et al.	726/35
*	B	US-6,018,800	01-2000	Ruckdashel, Glenn A.	726/35
*	C	US-4,985,920	01-1991	Seki, Junji	713/193
*	D	US-6,294,816	09-2001	Baukus et al.	257/368
*	E	US-6,629,061	09-2003	Shaffer, Larry J	702/188
*	F	US-5,182,770	01-1993	Medveczky et al.	705/56
*	G	US-4,601,034	07-1986	Sridhar, Thirumalai	714/732
*	H	US-4,291,404	09-1981	Steiner, William G.	714/724
*	I	US-5,363,380	11-1994	Shinohara, Makoto	714/25
*	J	US-6,198,669	03-2001	Iguchi, Minoru	365/189.07
*	K	US-6,820,063	11-2004	England et al.	705/54
*	L	US-2001/0037301	11-2001	Shepley et al.	705/43
*	M	US-6,606,744	08-2003	Mikurak, Michael G.	705/26

**FOREIGN PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	O					
	P					
	Q					
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**U.S. PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-6,775,779	08-2004	England et al.	726/26
*	B	US-6,779,112	08-2004	Guthery, Scott B.	713/172
*	C	US-6,000,004	12-1999	Fukumoto, Katsumi	711/103
	D	US-			
	E	US-			
	F	US-			
	G	US-			
	H	US-			
	I	US-			
	J	US-			
	K	US-			
	L	US-			
	M	US-			

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	N					
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